

Notice of References Cited	Application/Control No. 10/567,907		Applicant(s)/Patent Under Reexamination SHIGEMATSU ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,849,515 A	11-1974		528/274
*	B	US-4,187,355 A	02-1980	Wagner, Kuno	521/158
*	C	US-4,275,244 A	06-1981	Helfert et al.	568/624
*	D	US-4,609,763 A	09-1986	Griggs et al.	568/342
*	E	US-4,649,082 A	03-1987	Friedlander, Charles B.	428/461
*	F	US-4,820,794 A	04-1989	Darnell et al.	528/271
*	G	US-4,841,020 A	06-1989	Drent, Eit	528/392
*	H	US-4,940,758 A	07-1990	Wong, Pui K.	525/539
*	I	US-4,980,514 A	12-1990	Sanderson et al.	568/405
*	J	US-5,072,050 A	12-1991	Sanderson et al.	568/314
*	K	US-5,099,073 A	03-1992	Sanderson et al.	568/405
*	L	US-5,120,879 A	06-1992	Sanderson et al.	568/405
*	M	US-5,162,493 A	11-1992	Drent, Eit	528/392

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 1458570 A	12-1976	United Kingdom		
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,433,877 A	07-1995	Kono et al.	252/62.2
*	B	US-5,684,117 A	11-1997	Londa et al.	528/220
*	C	US-5,703,201 A	12-1997	Hanna, Paul K.	528/392
*	D	US-5,952,438 A	09-1999	Kratz et al.	525/471
*	E	US-6,222,009 B1	04-2001	Grant, Jr., Herbert W.	528/485
*	F	US-6,245,437 B1	06-2001	Shiiki et al.	428/483
*	G	US-6,277,929 B1	08-2001	Kitahara et al.	525/440.072
*	H	US-2002/0035238 A1	03-2002	Nakamura et al.	528/425
*	I	US-2003/0032688 A1	02-2003	Hotta et al.	521/130
*	J	US-6,528,572 B1	03-2003	Patel et al.	524/495
*	K	US-2003/0069390 A1	04-2003	Satoh et al.	528/425
*	L	US-2003/0064216 A1	04-2003	Tobita et al.	428/323
*	M	US-2003/0064017 A1	04-2003	Tobita et al.	423/447.2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0096104 A1	05-2003	Tobita et al.	428/332
*	B	US-2004/0167257 A1	08-2004	Ryang, Hong-Son	524/262
*	C	US-6,770,736 B1	08-2004	Haftka et al.	528/396
*	D	US-6,794,035 B2	09-2004	Tobita et al.	428/402
*	E	US-2004/0170554 A1	09-2004	Wadahara et al.	423/447.2
*	F	US-2005/0192369 A1	09-2005	Pazos et al.	521/155
*	G	US-2006/0025544 A1	02-2006	Koube et al.	525/437
*	H	US-2006/0135738 A1	06-2006	Taniguchi et al.	528/220
*	I	US-2006/0182922 A1	08-2006	Ishida et al.	428/044
*	J	US-7,166,754 B2	01-2007	Ferreira et al.	568/815
*	K	US-7,208,145 B2	04-2007	McManus et al.	424/78.27
*	L	US-7,223,829 B2	05-2007	Kato et al.	528/220
*	M	US-2003/0213939	11-2003	Narayan et al.	252/500

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	U	
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	X	

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